

November 2010

# FQD3P50TM\_F085

# **500V P-Channel MOSFET**

## **General Description**

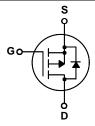
These P-Channel enhancement mode power field effect transistors are produced using Fairchild's proprietary, planar stripe, DMOS technology.

This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for electronic lamp ballast based on complimentary half bridge.

#### **Features**

- -2.1A, -500V,  $R_{DS(on)}$  = 4.9 $\Omega$  @V<sub>GS</sub> = -10 V Low gate charge ( typical 18 nC)
- Low Crss (typical 9.5 pF)
- Fast switching
- 100% avalanche tested
- · Improved dv/dt capability
- · Qualified to AEC Q101
- · RoHS Compliant





# Absolute Maximum Ratings T<sub>C</sub> = 25°C unless otherwise noted

Symbol	Parameter		FQD3P50TM_F085	Units	
V <sub>DSS</sub>	Drain-Source Voltage		-500	V	
I <sub>D</sub>	Drain Current - Continuous (T <sub>C</sub> = 25°	C)	-2.1	Α	
	- Continuous (T <sub>C</sub> = 100°C)		-1.33	Α	
I <sub>DM</sub>	Drain Current - Pulsed	(Note 1)	-8.4	Α	
V <sub>GSS</sub>	Gate-Source Voltage		± 30	V	
E <sub>AS</sub>	Single Pulsed Avalanche Energy	(Note 2)	250	mJ	
I <sub>AR</sub>	Avalanche Current	(Note 1)	-2.1	Α	
E <sub>AR</sub>	Repetitive Avalanche Energy	(Note 1)	5.0	mJ	
dv/dt	Peak Diode Recovery dv/dt (Note 3)		-4.5	V/ns	
$P_{D}$	Power Dissipation (T <sub>A</sub> = 25°C) *		2.5	W	
	Power Dissipation (T <sub>C</sub> = 25°C)		50	W	
	- Derate above 25°C		0.4	W/°C	
T <sub>J</sub> , T <sub>STG</sub>	Operating and Storage Temperature Range		-55 to +150	°C	
T <sub>L</sub>	Maximum lead temperature for soldering 1/8" from case for 5 seconds	g purposes,	300	°C	

# **Thermal Characteristics**

Symbol	Parameter	Тур	Max	Units
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case		2.5	°C/W
R <sub>θJA</sub> Thermal Resistance, Junction-to-Ambient *			50	°C/W
R <sub>θJA</sub> Thermal Resistance, Junction-to-Ambient			110	°C/W

Symbol	Parameter	Test Conditions	Min	Тур	Max	Units
Off Cha	aracteristics					
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = -250 \mu\text{A}$	-500			V
$\Delta BV_{DSS}$ / $\Delta T_{J}$	Breakdown Voltage Temperature  Ip = -250 µA, Referenced to 25°C			0.42		V/°C
I <sub>DSS</sub>	Zero Gate Voltage Drain Current	V <sub>DS</sub> = -500 V, V <sub>GS</sub> = 0 V		-	-1	μА
		V <sub>DS</sub> = -400 V, T <sub>C</sub> = 125°C			-10	μΑ
I <sub>GSSF</sub>	Gate-Body Leakage Current, Forward	V <sub>GS</sub> = -30 V, V <sub>DS</sub> = 0 V			-100	nA
I <sub>GSSR</sub>	Gate-Body Leakage Current, Reverse	V <sub>GS</sub> = 30 V, V <sub>DS</sub> = 0 V			100	nA
	racteristics					
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS} = V_{GS}, I_{D} = -250 \mu\text{A}$	-3.0		-5.0	V
R <sub>DS(on)</sub>	Static Drain-Source On-Resistance	$V_{GS} = -10 \text{ V}, I_D = -1.05 \text{ A}$		3.9	4.9	Ω
9 <sub>FS</sub>	Forward Transconductance	$V_{DS} = -50 \text{ V}, I_{D} = -1.05 \text{ A} \text{ (Note 4)}$		2.1		S
C <sub>iss</sub> C <sub>oss</sub> C <sub>rss</sub>	Input Capacitance Output Capacitance Reverse Transfer Capacitance	$V_{DS} = -25 \text{ V}, V_{GS} = 0 \text{ V},$ f = 1.0 MHz		510 70 9.5	90 12	pF pF
	ing Characteristics			9.5	12	рг
t <sub>d(on)</sub>	Turn-On Delay Time	V <sub>DD</sub> = -250 V, I <sub>D</sub> = -2.7 A,		12	35	ns
t <sub>r</sub>	Turn-On Rise Time	$R_{G} = 25 \Omega$		56	120	ns
t <sub>d(off)</sub>	Turn-Off Delay Time	1.6 2022		35	80	ns
t <sub>f</sub>	Turn-Off Fall Time	(Note 4, 5)		45	100	ns
Qg	Total Gate Charge	V <sub>DS</sub> = -400 V, I <sub>D</sub> = -2.7 A,		18	23	nC
Q <sub>gs</sub>	Gate-Source Charge	V <sub>GS</sub> = -10 V		3.6		nC
Q <sub>gd</sub>	Gate-Drain Charge	(Note 4, 5)		9.2		nC
<b>Drain-S</b>	Source Diode Characteristics at Maximum Continuous Drain-Source Dio	ode Forward Current			-2.1	А
	Maximum Pulsed Drain-Source Diode Forward Current				-8.4	Α
I <sub>SM</sub>						
I <sub>SM</sub> V <sub>SD</sub>	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -2.1 \text{ A}$		-	-5.0	V
	Drain-Source Diode Forward Voltage Reverse Recovery Time	$V_{GS} = 0 \text{ V, } I_S = -2.1 \text{ A}$ $V_{GS} = 0 \text{ V, } I_S = -2.7 \text{ A,}$ $dI_F / dt = 100 \text{ A/}\mu\text{s}$ (Note 4)		270	-5.0 	V ns

- **Notes:**1. Repetitive Rating : Pulse width limited by maximum junction temperature 2. L = 102mH, I<sub>AS</sub> = -2.1A, V<sub>DD</sub> = -50V, R<sub>G</sub> = 25  $\Omega$ , Starting T<sub>J</sub> = 25°C 3. I<sub>SD</sub>  $\leq$  -2.7A, di/dt  $\leq$  200 $\Delta$ /μs, V<sub>DD</sub>  $\leq$  BV<sub>DSS</sub>, Starting T<sub>J</sub> = 25°C 4. Pulse Test : Pulse width  $\leq$  300 $\mu$ s, Duty cycle  $\leq$  2% 5. Essentially independent of operating temperature

# **Typical Characteristics**

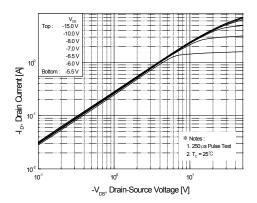


Figure 1. On-Region Characteristics

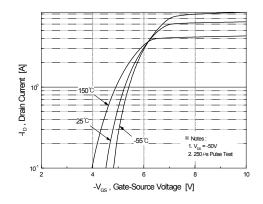


Figure 2. Transfer Characteristics

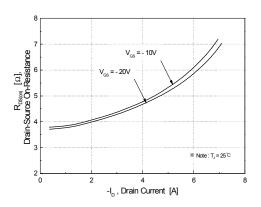


Figure 3. On-Resistance Variation vs. Drain Current and Gate Voltage

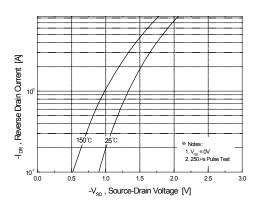


Figure 4. Body Diode Forward Voltage Variation vs. Source Current and Temperature

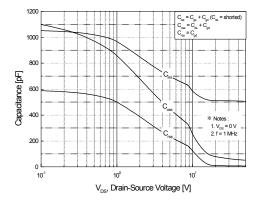


Figure 5. Capacitance Characteristics

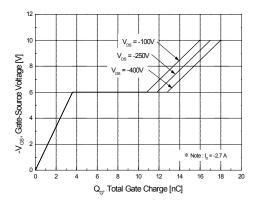
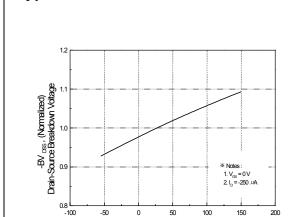


Figure 6. Gate Charge Characteristics



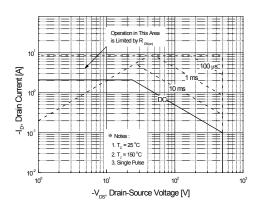
Typical Characteristics (Continued)

2.5 (Nonzajesto) 1.5 (N

Figure 7. Breakdown Voltage Variation vs. Temperature

 $T_J$ , Junction Temperature [°C]

Figure 8. On-Resistance Variation vs. Temperature



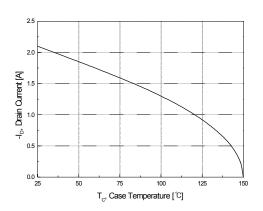


Figure 9. Maximum Safe Operating Area

Figure 10. Maximum Drain Current vs. Case Temperature

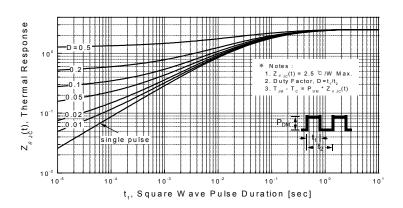
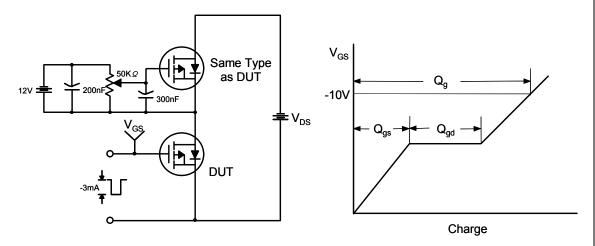
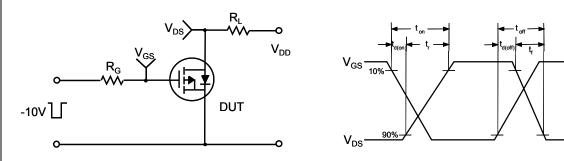


Figure 11. Transient Thermal Response Curve

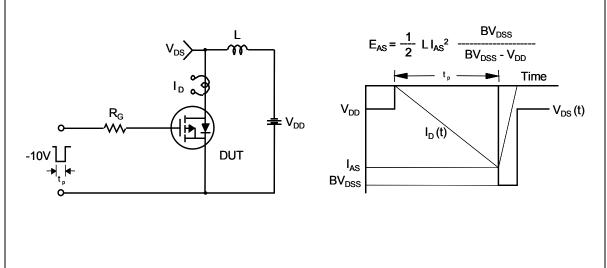
# **Gate Charge Test Circuit & Waveform**



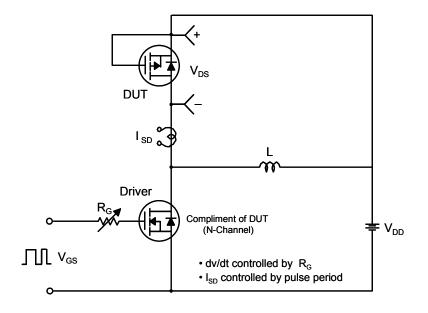
# **Resistive Switching Test Circuit & Waveforms**

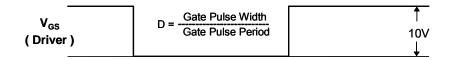


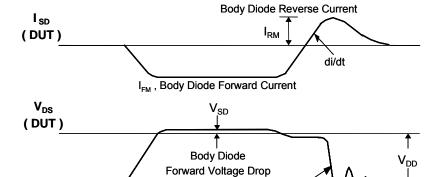
### **Unclamped Inductive Switching Test Circuit & Waveforms**



### Peak Diode Recovery dv/dt Test Circuit & Waveforms





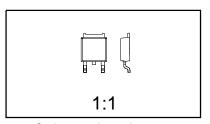


Body Diode Recovery dv/dt

### **Mechanical Dimensions**

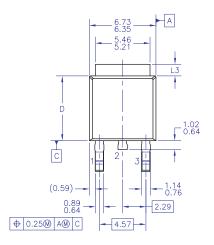
# TO-252 (DPAK) (FS PKG Code 36)

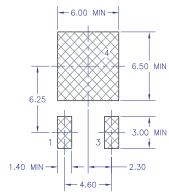




Scale 1:1 on letter size paper Dimensions shown below are in: millimeters

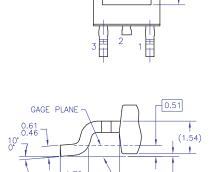
Part Weight per unit (gram): 0.33





SEE DETAIL A

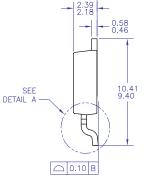
LAND PATTERN RECOMMENDATION



0.127 MAX - SEATING PLANE

DETAIL A (ROTATED -90°) SCALE: 12X

SEE NOTE D



NOTES: UNLESS OTHERWISE SPECIFIED

- ALL DIMENSIONS ARE IN MILLIMETERS.
  THIS PACKAGE CONFORMS TO JEDEC, TO-252,
  ISSUE C, VARIATION AA & AB, DATED NOV. 1999.

- DIMENSIONING AND TOLERANCING PER
  ASME Y14.5M-1994.
  HEAT SINK TOP EDGE COULD BE IN CHAMFERED
  CORNERS OR EDGE PROTRUSION.
  DIMENSIONS L3,D,E1&D1 TABLE:

	OPTION AA	OPTION AB
L3	0.89-1.27	1.52-2.03
D	5.97-6.22	5.33-5.59
E1	4.32 MIN	3.81 MIN
D1	5.21 MIN	4.57 MIN





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